

**Search Notes**

Application/Control No.

10/620,456

Examiner

Paul Contino

Applicant(s)/Patent under  
Reexamination

LEE, CHIN

Art Unit

2114

**SEARCHED**

Class	Subclass	Date	Examiner
714	718	11/29/2006	PFC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR.
Inventor Search	11/28/2006	PFC
EAST (all databases searched)	11/29/2006	PFC
714/4,42,54,718,719 - text searched [see included search report]	11/28/2006	PFC
ACM/IEEE (+test +memory/"multiple/plurality of memory" +compare [+sdram])	11/29/2006	PFC